

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/603,945 KROITZSCH ET AL.	
		Examiner	Art Unit John A. Tweel, Jr.	2636      Page 1 of 1

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	K	US-			
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	M	US-			

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**NON-PATENT DOCUMENTS**

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